

N-Channel Logic Level Enhancement Mode Power MOSFET

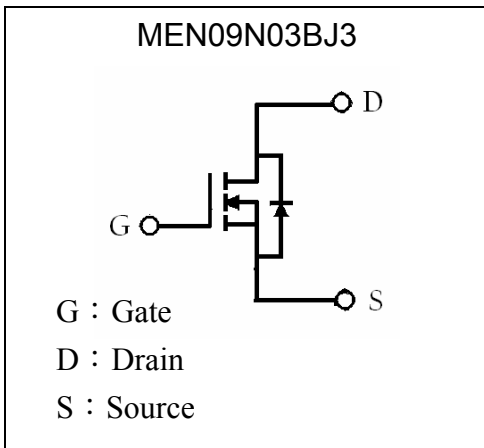
MEN09N03BJ3

BV_{DSS}	30V
I_D	50A
$R_{DSON(MAX)}$	9mΩ

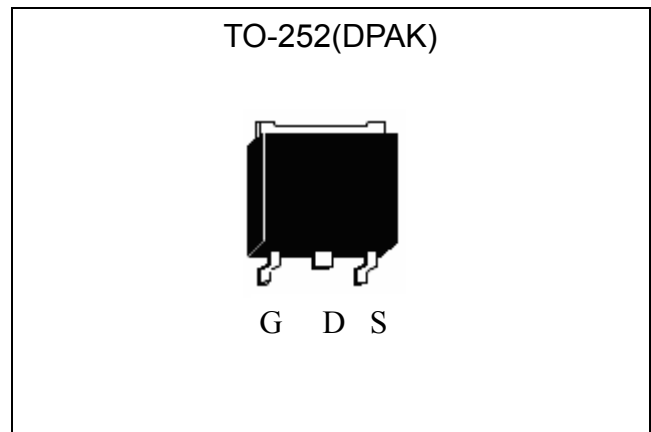
Features

- $V_{DS}=30V, I_D=50A, R_{DS(ON)}=9m\Omega$
- Low Gate Charge
- Simple Drive Requirement
- RoHS compliant package
- Repetitive Avalanche Rated
- Fast Switching Characteristic

Symbol

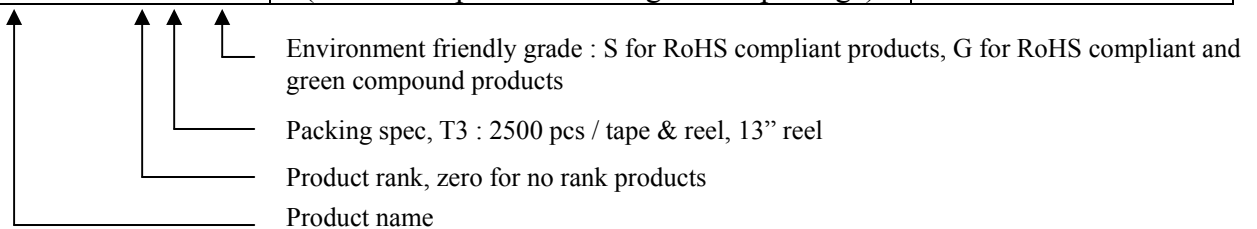


Outline



Ordering Information

Device	Package	Shipping
MEN09N03BJ3-0-T3-G	TO-252 (RoHS compliant and halogen-free package)	2500 pcs / Tape & Reel





Absolute Maximum Ratings (Tc=25°C)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V _{DS}	30	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current @ Tc=25°C	I _D	50	A
Continuous Drain Current @ Tc=100°C	I _D	35	A
Pulsed Drain Current	I _{DM}	140 *1	A
Avalanche Current	I _{AS}	37.5	A
Avalanche Energy @ L=0.1mH, I _D =37.5A, R _g =25Ω	E _{AS}	70	mJ
Repetitive Avalanche Energy @ L=0.05mH	E _{AR}	15 *2	mJ
Power Dissipation (Tc=25°C)	P _D	60	W
Power Dissipation (Tc=100°C)		32	W
Operating Junction and Storage Temperature	T _j , T _{stg}	-55~+175	°C

100% UIS testing in condition of V_D=15V, L=0.1mH, V_G=10V, I_L=25A, Rated V_{DS}=25V N-CH

Note : *1. Pulse width limited by maximum junction temperature
 *2. Duty cycle≤1%

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	R _{th,j-c}	2.5	°C/W
Thermal Resistance, Junction-to-ambient, max	R _{th,j-a}	75	°C/W

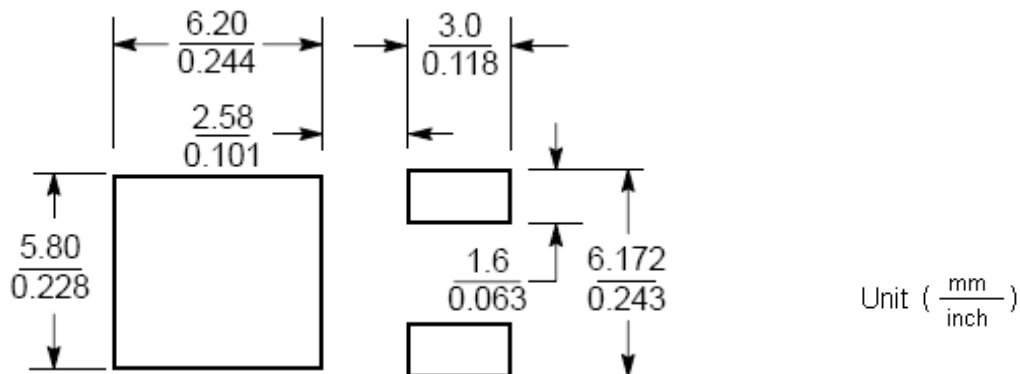
Characteristics (Tc=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	30	-	-	V	V _{GS} =0, I _D =250μA
V _{GS(th)}	1.0	1.7	3.0	V	V _{DS} = V _{GS} , I _D =250μA
G _{FS}	-	20	-	S	V _{DS} =5V, I _D =20A
I _{GSS}	-	-	±100	nA	V _{GS} =±20
I _{DSS}	-	-	1	μA	V _{DS} =24V, V _{GS} =0
	-	-	25		V _{DS} =20V, V _{GS} =0, T _j =125°C
I _{D(ON)}	50	-	-	A	V _{GS} =10V, V _{DS} =10V
*R _{DS(ON)}	-	7	9	mΩ	V _{GS} =10V, I _D =25A
	-	10	15		V _{GS} =5V, I _D =20A
Dynamic					
R _g	-	1.7	-	Ω	V _{GS} =15mV, V _{DS} =0, f=1MHz
*Q _g (V _{GS} =10V)	-	23	-	nC	I _D =25A, V _{DS} =15V, V _{GS} =10V
*Q _g (V _{GS} =5V)	-	13	-		
*Q _{gs}	-	4.6	-		
*Q _{gd}	-	10	-		

*td(ON)	-	8	-	ns	V _{DS} =15V, I _D =25A, V _{GS} =10V, R _G =2.7Ω, R _D =0.6Ω
*tr	-	6	-		
*td(OFF)	-	30	-		
*tf	-	8	-		
Ciss	-	1638	-	pF	V _{GS} =0V, V _{DS} =15V, f=1MHz
Coss	-	176	-		
Crss	-	141	-		
Source-Drain Diode					
*I _S	-	-	50	A	
*I _{SM}	-	-	140		
*V _{SD}	-	-	1.3	V	I _F =I _S , V _{GS} =0
*trr	-	22	-	ns	I _F =I _S , dI _F /dt=100A/μs
*I _{RM(REC)}	-	180	-	A	
*Q _{rr}	-	12	-	nC	

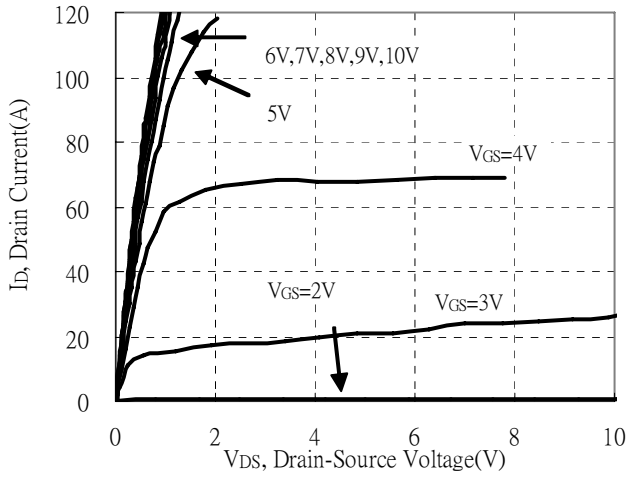
*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

Recommended soldering footprint

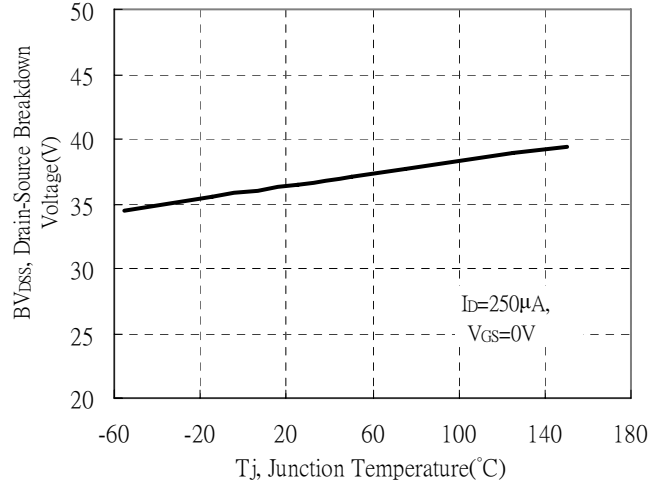


Typical Characteristics

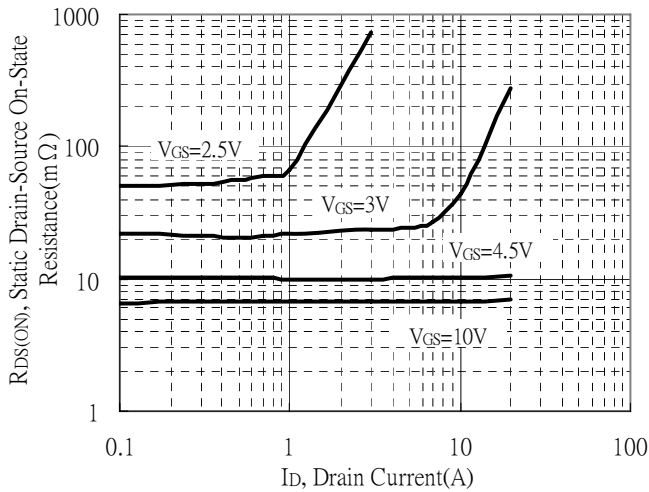
Typical Output Characteristics



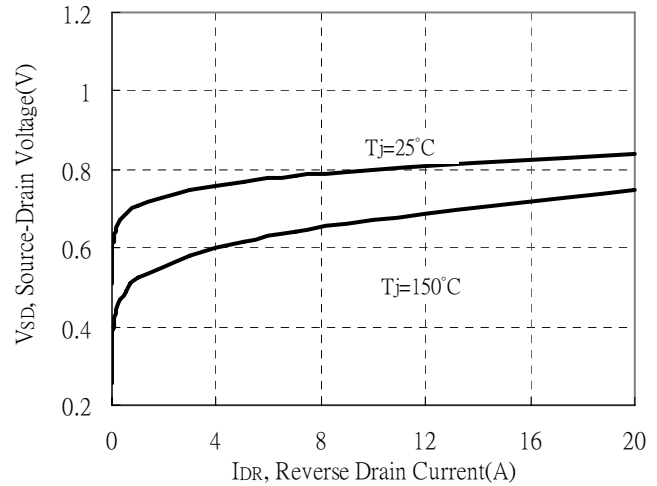
Brekdown Voltage vs Ambient Temperature



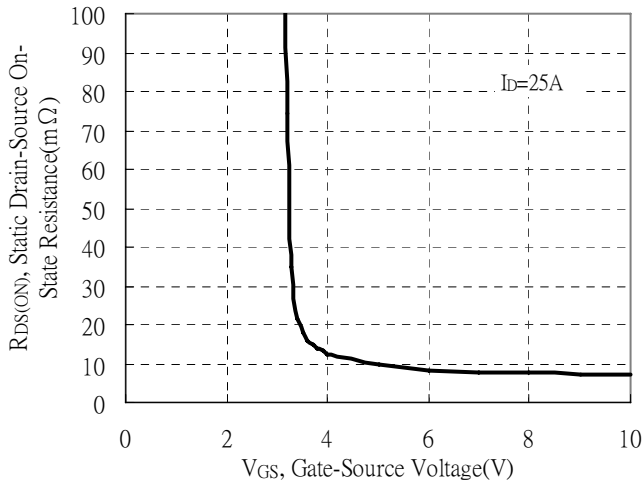
Static Drain-Source On-State resistance vs Drain Current



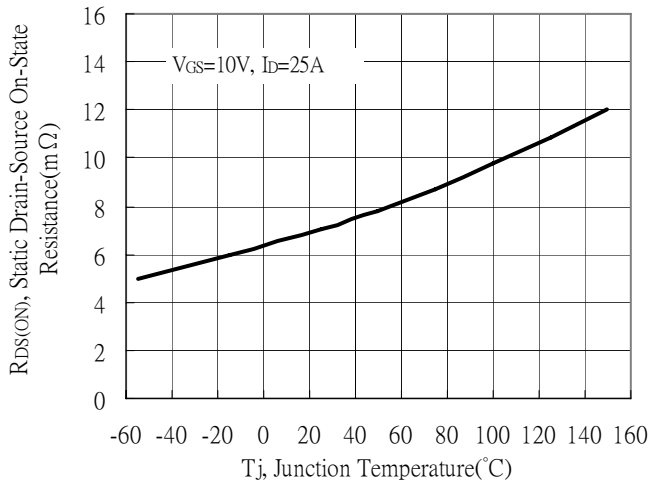
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage



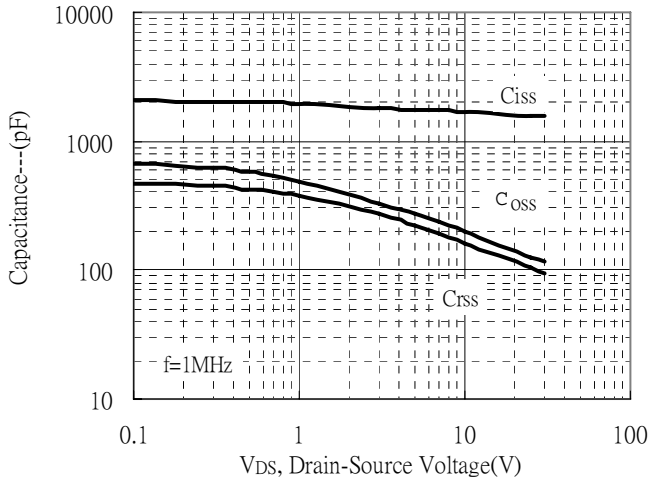
Drain-Source On-State Resistance vs Junction Temperature



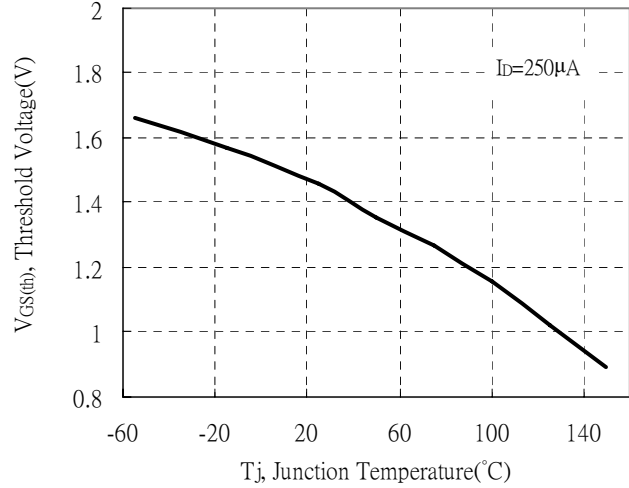


Typical Characteristics(Cont.)

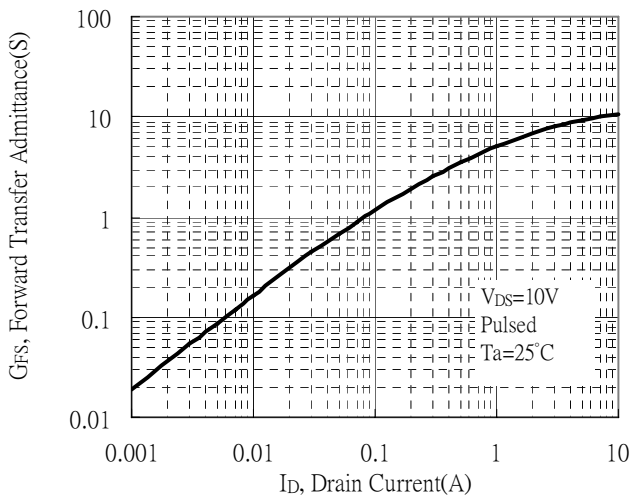
Capacitance vs Drain-to-Source Voltage



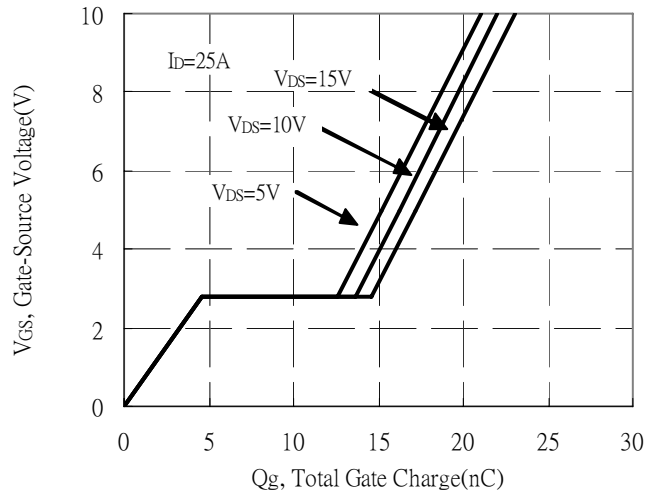
Threshold Voltage vs Junction Temperature



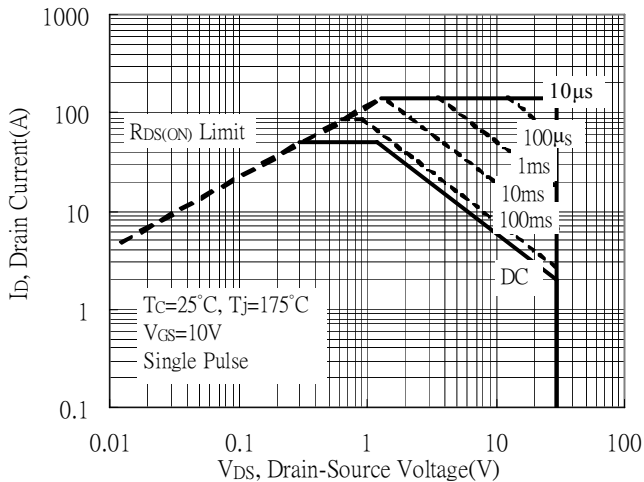
Forward Transfer Admittance vs Drain Current



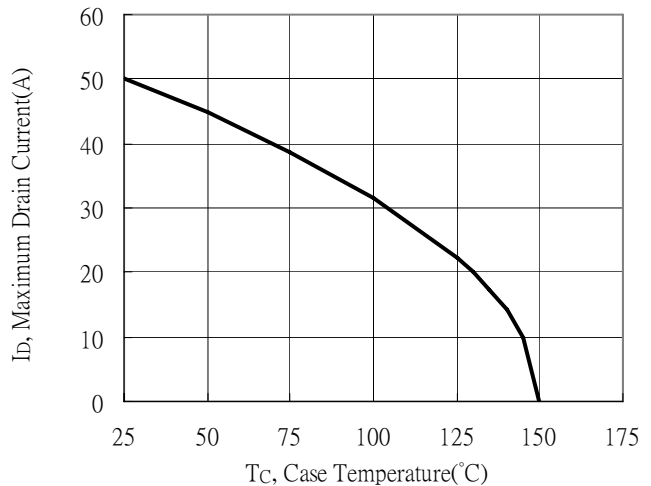
Gate Charge Characteristics



Maximum Safe Operating Area

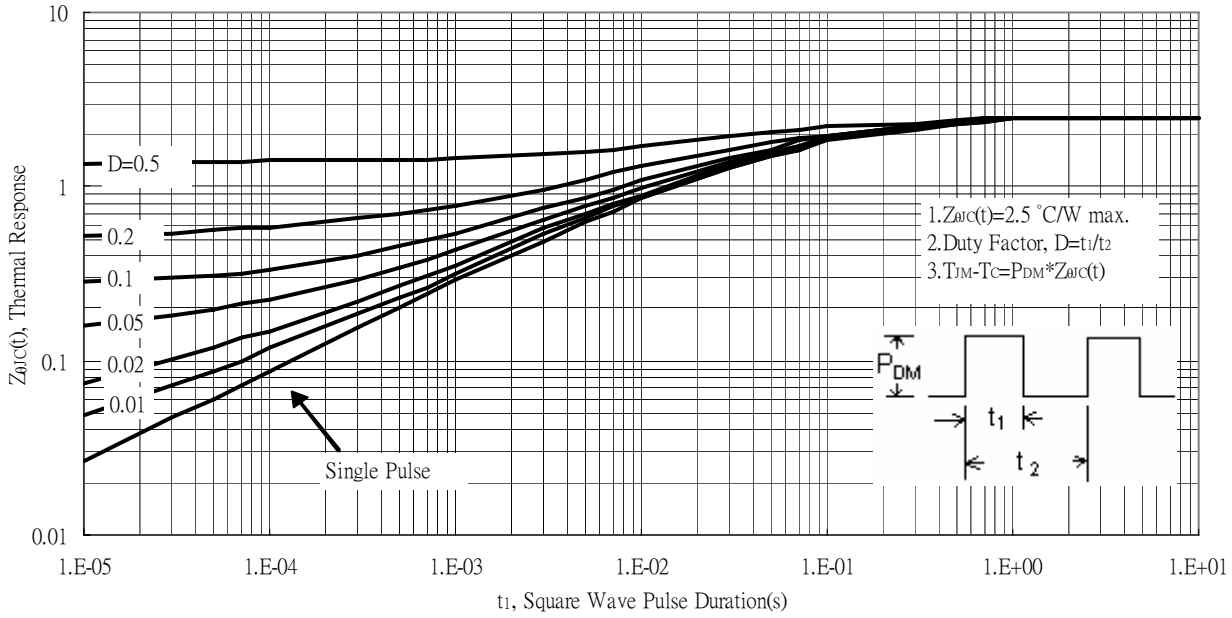


Maximum Drain Current vs Case Temperature



Typical Characteristics(Cont.)

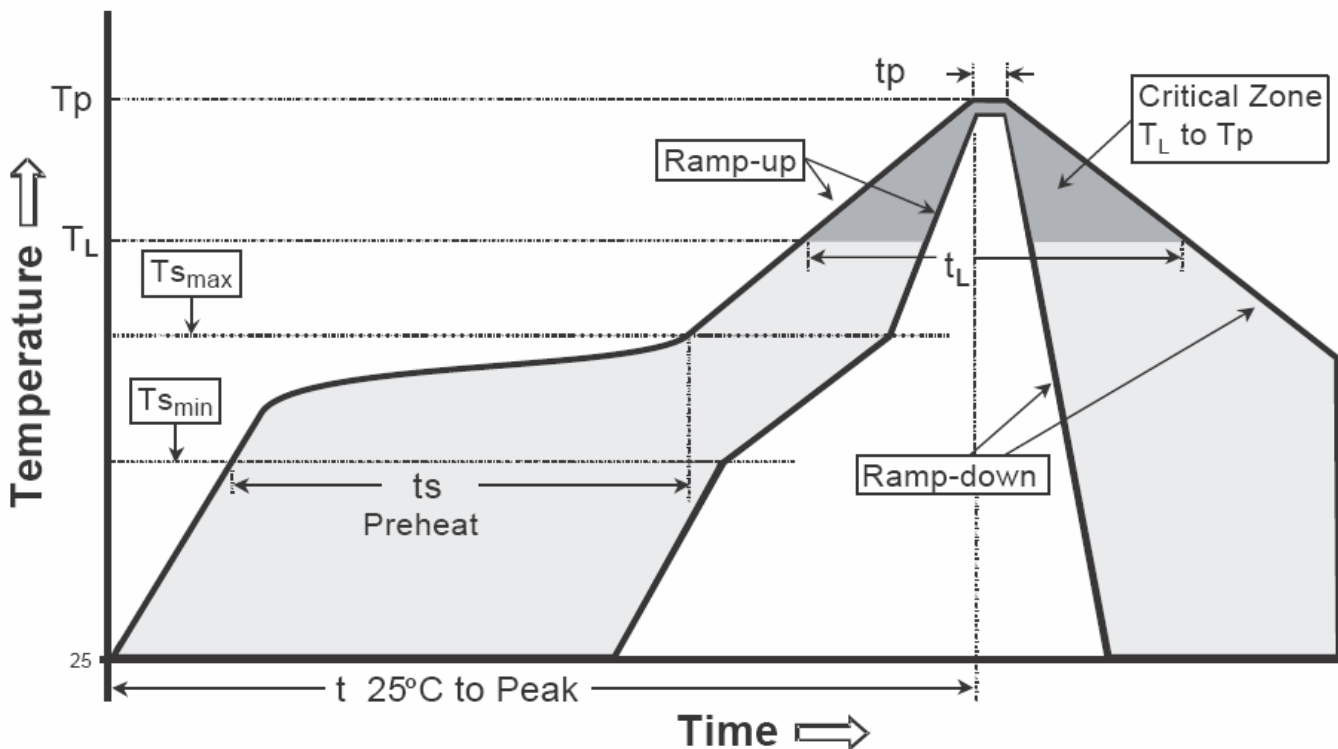
Transient Thermal Response Curves



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

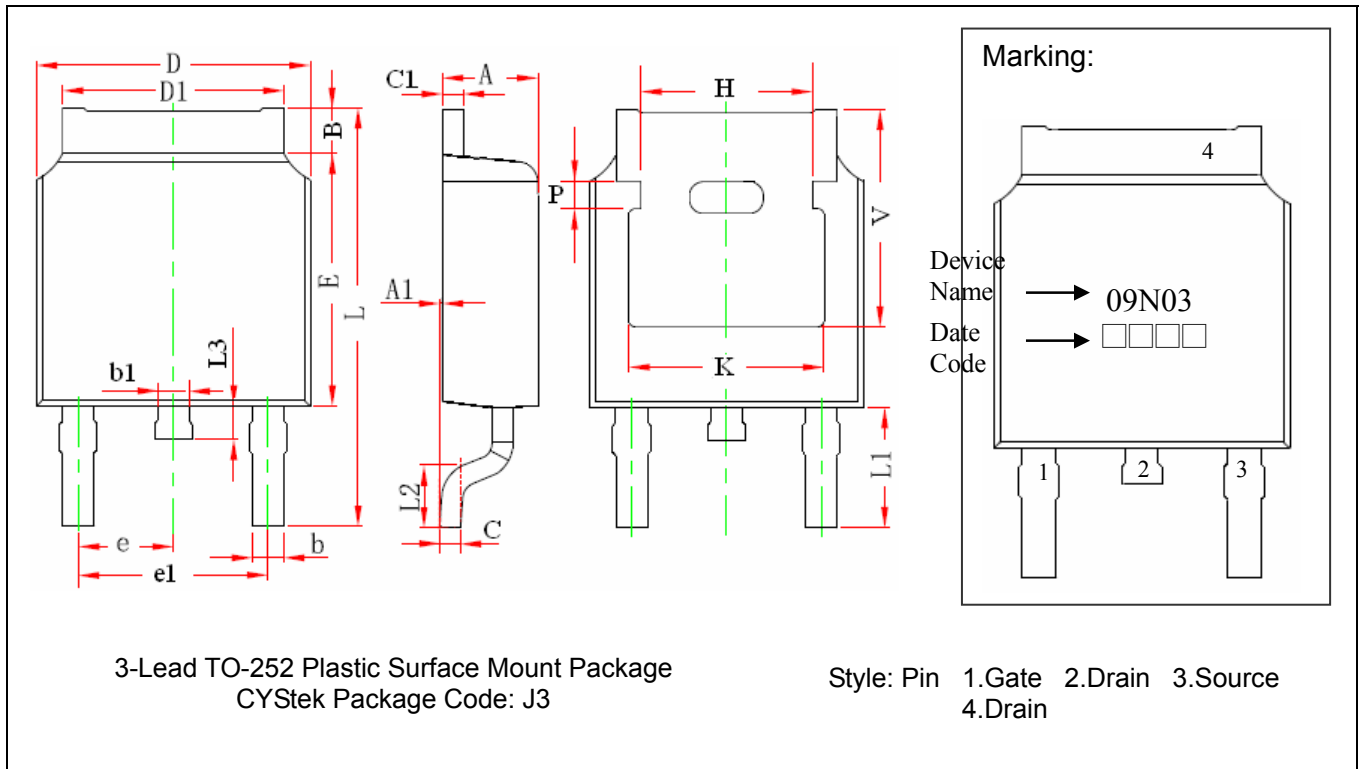
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T _{smax} to T _p)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T _{s min})	100°C	150°C
-Temperature Max(T _{s max})	150°C	200°C
-Time(t _{s min} to t _{s max})	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T _L)	183°C	217°C
- Time (t _L)	60-150 seconds	60-150 seconds
Peak Temperature(T _P)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

TO-252 Dimension



DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.087	0.094	2.200	2.400	e	0.086	0.094	2.186	2.386
A1	0.000	0.005	0.000	0.127	e1	0.172	0.188	4.372	4.772
B	0.039	0.048	0.990	1.210	H	0.163	REF	4.140	REF
b	0.026	0.034	0.660	0.860	K	0.190	REF	4.830	REF
b1	0.026	0.034	0.660	0.860	L	0.386	0.409	9.800	10.400
C	0.018	0.023	0.460	0.580	L1	0.114	REF	2.900	REF
C1	0.018	0.023	0.460	0.580	L2	0.055	0.067	1.400	1.700
D	0.256	0.264	6.500	6.700	L3	0.024	0.039	0.600	1.000
D1	0.201	0.215	5.100	5.460	P	0.026	REF	0.650	REF
E	0.236	0.244	6.000	6.200	V	0.211	REF	5.350	REF

Notes: 1.Controlling dimension: millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead : Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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